CLAIMS

1. A diamond n-type semiconductor comprising a first diamond semiconductor having n-type conduction;

wherein, in said first diamond semiconductor, a conductor exhibits an electron concentration negatively correlated with temperature in a temperature range of at least 100°C within at least the temperature region from 0°C to 300°C.

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- 2. A diamond n-type semiconductor according to claim 1, wherein, in said first diamond semiconductor, the conductor exhibits a Hall coefficient positively correlated with temperature in a temperature range of at least 100°C within at least the temperature region from 0°C to 300°C.
- 3. A diamond n-type semiconductor according to claim 1 or 2, wherein the temperature range exists over at least 200°C within the temperature region from 0°C to 300°C.
- 4. A diamond n-type semiconductor according to any one of claims 1 to 3, wherein said first diamond semiconductor has a resistivity of 500 Ω cm or less at least at a temperature within the temperature region from 0°C to 300°C.
- 5. A diamond n-type semiconductor according to any one of claims 1 to 4, wherein the electron concentration of said first diamond semiconductor is always at least 10¹⁶ cm⁻³ in the temperature region from 0°C to 300°C.
- 6. A diamond n-type semiconductor according to any one of claims 1 to 5, wherein said first diamond semiconductor contains more than 5×10^{19} cm⁻³ in total of at least one kind of donor element.

- 7. A diamond n-type semiconductor according to claim 6, wherein said first diamond semiconductor contains at least P (phosphorus) as the donor element.
- 8. A diamond n-type semiconductor according to claim 6, wherein said first diamond semiconductor contains at least S (sulfur) as the donor element.

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- 9. A diamond n-type semiconductor according to any one of claims 1 to 8, wherein said first diamond semiconductor contains an impurity element other than the donor element together with the donor element.
- 10. A diamond n-type semiconductor according to claim 9, wherein said first diamond semiconductor contains at least 1×10^{17} cm⁻³ of Si as the impurity element.
- 11. A diamond n-type semiconductor according to any one of claims 1 to 10, wherein said first diamond semiconductor is monocrystal diamond.
- 12. A diamond n-type semiconductor according to any one of claims 1 to 11, further comprising a second diamond semiconductor provided adjacent to said first diamond semiconductor and turned out to be n-type,

wherein, in said second diamond semiconductor, a conductor exhibits an electron concentration not negatively correlated with temperature and a Hall coefficient not positively correlated with temperature.

13. A semiconductor device at least partly employing a diamond n-type semiconductor according to any one of claims 1 to 12.

- 14. An electron emitting device having the diamond n-type semiconductor according to any one of claims 1 to 12 employed in at least an electron emitting part thereof.
- 15. A method of manufacturing a diamond n-type semiconductor according to any one of claims 1 to 12, said method comprising the steps of:

preparing a diamond substrate; and

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epitaxially growing said first diamond semiconductor on said diamond substrate while artificially introducing an impurity element other than a donor element to said diamond substrate.

16. A method of manufacturing a diamond n-type semiconductor according to claim 15, wherein Si is artificially introduced as the impurity element to said diamond substrate.